

<b>Notice of References Cited</b>	Application/Control No. 10/722,678 , 901007164		Applicant(s)/Patent Under Reexamination ISHIDA ET AL.	
	Examiner Lien T. Tran		Art Unit 1761	Page 1 of 1

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*	C	US-5,510,508	04-1996	Claude et al.	560/41
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	K	US-			
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**NON-PATENT DOCUMENTS**

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9/6/05